

## SI4413DY-T1-E3-VB Datasheet

## P-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>d</sup>	Q <sub>g</sub> (Typ.)			
- 30	0.011 at V <sub>GS</sub> = - 10 V	- 11.6	22 nC			
- 30	0.012 at V <sub>GS</sub> = - 4.5 V	- 10	22110			

#### **FEATURES**

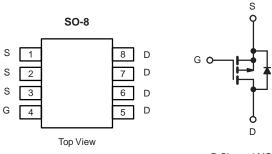
- Halogen-free According to IEC 61249-2-21 Available
- TrenchFET<sup>®</sup> Power MOSFET
- 100 % R<sub>g</sub> Tested
  100 % UIS Tested

#### **APPLICATIONS**

- Load Switches
- Notebook PCs
- Desktop PCs



COMPLIANT HALOGEN FREE Available



#### P-Channel MOSFET

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	- 30	V	
Gate-Source Voltage	V <sub>GS</sub>	± 20	v	
	T <sub>C</sub> = 25 °C		- 11.6	
Continuous Drain Current ( $T_1 = 150 \text{ °C}$ )	T <sub>C</sub> = 70 °C		- 10.5	
Continuous Drain Current $(1_j = 150 \text{ C})$	T <sub>A</sub> = 25 °C	I <sub>D</sub>	- 8.7 <sup>a, b</sup>	
	T <sub>A</sub> = 70 °C	1	- 7.7 <sup>a, b</sup>	^
Pulsed Drain Current	I <sub>DM</sub>	- 40	— A	
	T <sub>C</sub> = 25 °C		- 4.6	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	- I <sub>S</sub>	2.0 <sup>a, b</sup>	
Avalanche Current		I <sub>AS</sub>	- 20	
Single-Pulse Avalanche Energy	L = 0.1 mH	E <sub>AS</sub>	20	mJ
	T <sub>C</sub> = 25 °C		5.6	
Maximum Dawar Dissinction	T <sub>C</sub> = 70 °C		3.6	W
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	– P <sub>D</sub> –	2.5 <sup>a, b</sup>	VV
	T <sub>A</sub> = 70 °C	1	1.6 <sup>a, b</sup>	
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stq</sub>	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>a, c</sup>	t ≤ 10 s	R <sub>thJA</sub>	39	50	°C/W	
Maximum Junction-to-Foot	Steady State	R <sub>thJF</sub>	18	22	°C/vv	

Notes:

a. Surface mounted on 1" x 1" FR4 board.

b. t = 10 s.

c. Maximum under Steady State conditions is 85 °C/W. d. Based on  $T_C = 25$  °C.

S	3	® VI	Bse	mi
ww	vw.V	'Bse	emi.	com

Parameter	, unless othe Symbol	Test Conditions	Min.	Typ	Max.	Unit
Static	Symbol	Test conditions	win.	Тур.	wax.	Unit
	V	$y' = 0y' = -250 u^{2}$	20			
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 V, I_D = -250 \mu A$	- 30	24		V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = - 250 μA		- 31		mV/°C
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			5.5		
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = -250 \mu\text{A}$	- 1.0		- 3.0	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 25 V$			± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = -30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$ $V_{DS} = -30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 \text{ °C}$			- 1 - 5	μA
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge -10 \text{ V}, \text{ V}_{GS} = -10 \text{ V}$	- 30			Α
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS}$ = - 10 V, I <sub>D</sub> = - 10 A $V_{GS}$ = - 4.5 V, I <sub>D</sub> = - 7 A		0.011		Ω
Forward Transconductance <sup>a</sup>	g <sub>fs</sub>	$V_{DS} = -10 \text{ V}, I_D = -10 \text{ A}$		23		S
Dynamic <sup>b</sup>	315					
Input Capacitance	C <sub>iss</sub>			1960		
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz		380		pF
Reverse Transfer Capacitance	C <sub>rss</sub>			325		- PE
		V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 10 A		43	65	
Total Gate Charge	Qg			22	33	nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 10 A		6		
Gate-Drain Charge	Q <sub>gd</sub>			11		
Gate Resistance	Rg	f = 1 MHz	0.3	1.3	2.5	Ω
Turn-On Delay Time	t <sub>d(on)</sub>			11	22	
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 15 V, $R_L$ = 3 $\Omega$		13	25	-
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong -5 \text{ A}, V_{GEN} = -10 \text{ V}, \text{ R}_{g} = 1 \Omega$		32	50	
Fall Time	t <sub>f</sub>			9	18	
Turn-On Delay Time	t <sub>d(on)</sub>			44	70	ns
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 15 V, $R_L$ = 3 $\Omega$		100	160	
Turn-Off DelayTime	t <sub>d(off)</sub>	I <sub>D</sub> ≅ - 5 A, V <sub>GEN</sub> = - 4.5 V, R <sub>g</sub> = 1 Ω		28	50	
Fall Time	t <sub>f</sub>			15	30	
Drain-Source Body Diode Characterist	ics			1	1	1
Continuous Source-Drain Diode Current	۱ <sub>s</sub>	T <sub>C</sub> = 25 °C			- 4.6	
Pulse Diode Forward Current	I <sub>SM</sub>	-			- 50	A
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = - 2 A, V <sub>GS</sub> = 0 V		- 0.75	- 1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			28	45	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			20	40	nC
Reverse Recovery Fall Time	t <sub>a</sub>	I <sub>F</sub> = - 2 A, dl/dt = 100 A/μs, T <sub>J</sub> = 25 °C		13		
Reverse Recovery Rise Time	t <sub>b</sub>			15		ns

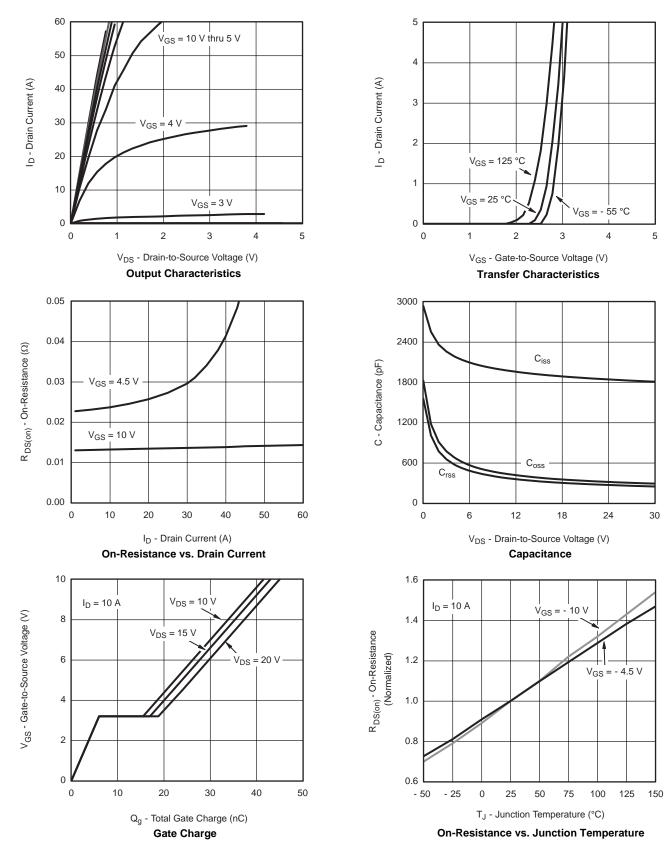
Notes:

a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %.

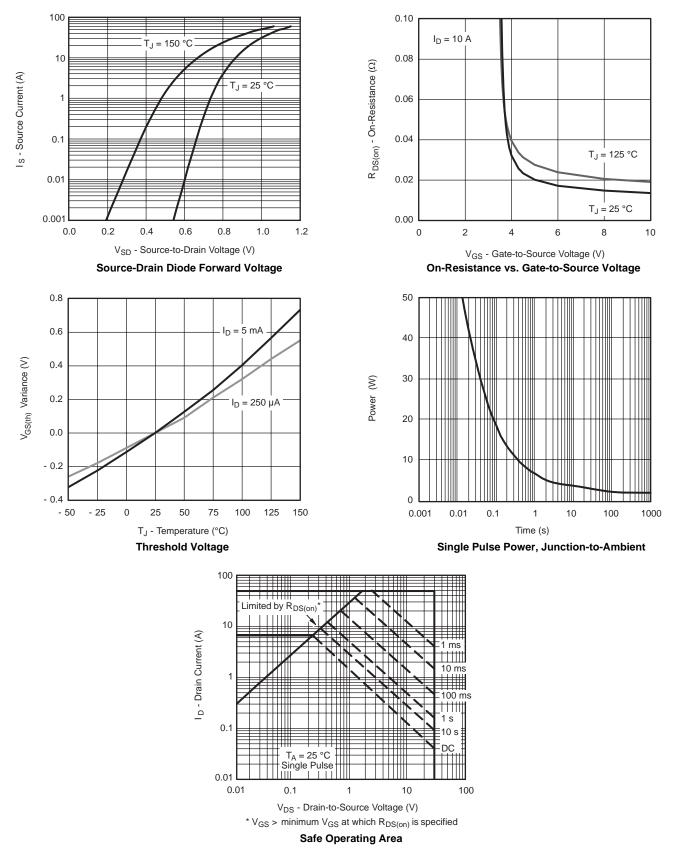
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

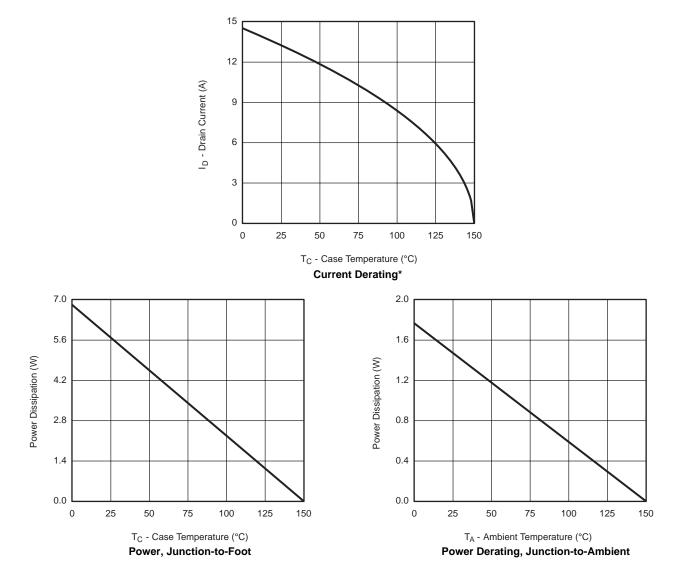






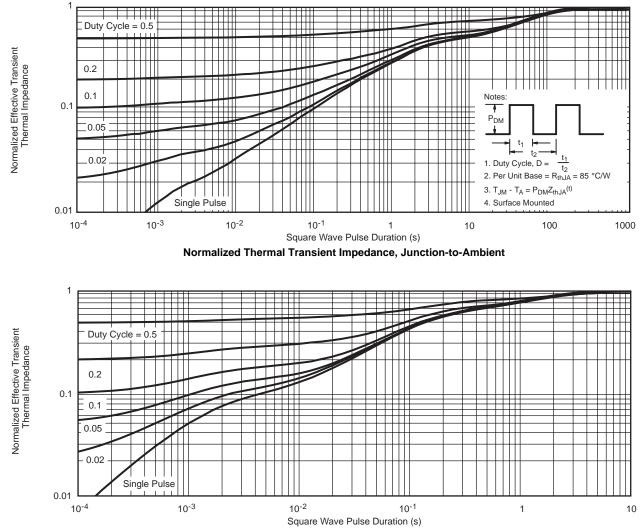






\* The power dissipation  $P_D$  is based on  $T_{J(max)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



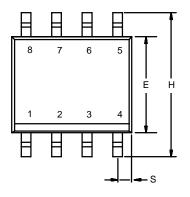


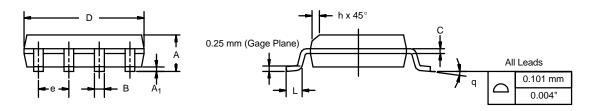
Normalized Thermal Transient Impedance, Junction-to-Foot



### SOIC (NARROW): 8-LEAD

JEDEC Part Number: MS-012

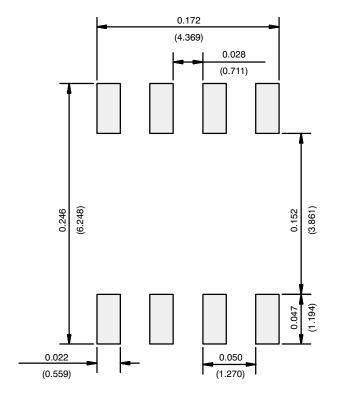




	MILLIMETERS		INC	HES		
DIM	Min	Мах	Min	Max		
A	1.35	1.75	0.053	0.069		
A <sub>1</sub>	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
E	3.80	4.00	0.150	0.157		
е	1.27	BSC	0.050 BSC			
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
ECN: C-06527-Rev. I, 11-Sep-06 DWG: 5498						



#### **RECOMMENDED MINIMUM PADS FOR SO-8**



Recommended Minimum Pads Dimensions in Inches/(mm)



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